

Product Change Notification / ASER-15HQCX332

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20-Oct-2021

Product Category:

Analog to Digital Converters

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4903 Final Notice: Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package.

Affected CPNs:

ASER-15HQCX332_Affected_CPN_10202021.pdf ASER-15HQCX332_Affected_CPN_10202021.csv

Notification Text:

PCN Status:Final Notification

PCN Type:Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section. Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change:Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package.

Pre and Post Change Summary:

	Pre Change	Post Change
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Assembly Site	UTAC Thai Limited (UTL-1) LTD. (NSEB)	UTAC Thai Limited (UTL-1) LTD. (NSEB)	
Wire Material	Au	Au	
Die Attach Material	8200T	8200T	
Molding Compound Material	G600	G600	
Lead-Frame Material	C7025	C7025	
Lead-Frame Paddle Size	82x94 mil	68x94 mil	
	No	Yes	
Lead-Frame Lead Lock	See Pre and Post Change Summary for comparison.		

Impacts to Data Sheet:None

Change ImpactNone

Reason for Change:To improve productivity by qualifying a new lead frame design.

Change Implementation Status:In Progress

Estimated First Ship Date:10/30/21 (date code: 2144)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	October 2021				
Workweek	4	4	4	4	4
	1	2	3	4	5
Qual Report			,,		
Availability			Х		
Final PCN Issue			,,		
Date			Х		
Estimated					
Implementation				Х	
Date					

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:October 20, 2021: Issued final notification.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_ASER-15HQCX332 Qual Report 1 of 2.pdf PCN_ASER-15HQCX332 Qual Report 2 of 2.pdf PCN_ASER-15HQCX332_Pre and Post Change Summary.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

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If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.



QUALIFICATION REPORT SUMMARY

PCN #: ASER-15HQCX332

Date: Aug 05, 2019

Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package. This is a qualification by similarity.



Purpose Qualification of a new lead frame design for selected MCP342xxx device family available in

10L MSOP (3x3mm) package. This is a qualification by similarity.

CCB 2929.001 & 4903

CN ES295627

QUAL ID Q19076 Rev. A MP CODE TAPA44E3XA11

 Part No.
 MCP33111-10-E/MS

 Bonding No.
 BDE-005353 Rev. 01

Package

Type 10L MSOP Package size 3 x 3 mm.

Lead Frame

Paddle size 82 x 94 mils

Material C7025

Surface Ag Spot plated

Process Stamped

Lead Lock No

Part Number FM0009
Treatment None

Material

Epoxy 8200T
Wire Au wire
Mold Compound G600
Plating Composition Matte Tin



Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
NSEB200400001.000	TC08919468004.400	1917T0M
NSEB200400002.000	TC08919468004.400	1917T0R
NSEB200400003.000	TC08919468004.400	1917T0T

Result	X	Pass	Fail		
				-	

10L MSOP assembled by NSEB pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT						
Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/S S	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020E)	IPC/JEDE C J-STD- 020E	135	0/135	Pass	

Precondition Prior Perform	Electrical Test :+25°C and 125°C System: J750_HD	JESD22- A113	693(0)	693		Good Devices
Reliability Tests (At MSL Level 1)	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max			693		
	System: Vitronics Soltec MR1243					
	Electrical Test :+25°C and 125°C System: J750_HD			0/693	Pass	

PACKAGE QUALIFICATION REPORT						
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C
Temp Cycle	Electrical Test: + 125°C System: J750 HD		231(0)	0/231	Pass	77 units / lot
. Simp Gyold	Bond Strength: Wire Pull (> 2.5 grams) Bond Shear (>15.00 grams)		15 (0) 15 (0)	0/15 0/15	Pass Pass	

	PACKAGE QUALIFIC	ATION	IREF	PORT	•	
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Solderability Temp 245°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22 0/22	Pass	
Physical Dimensions	Physical Dimension, 10 units from 1 lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
Bond Strength	Wire Pull (> 2.5 grams)	M2011	30 (0) Wires	0/30	Pass	
Data Assembly	Bond Shear (>15.00 grams)	JESD22- B116	30 (0) bonds	0/30	Pass	



QUALIFICATION REPORT SUMMARY

PCN #: ASER-15HQCX332

Date: June 14, 2016

Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package. This is a qualification by similarity.



Purpose Qualification of a new lead frame design for selected MCP342xxx device family

available in 10L MSOP (3x3mm) package. This is a qualification by similarity.

CCB 2503 & 4903 **CN** BC161017

QUAL ID
Q16048 Rev. A
MP CODE
VABA1YE3XA00
Part No.
HV9805MG-G
Bonding No.
A-053196 Rev. B

<u>Package</u>

Type 10L MSOP Package size 3x3 mm

Lead Frame

Paddle size 68 x 94 mils

Material C7025

Surface Spot Ag Plated

Process Stamped

Lead Lock Yes

Part Number FM0008
Treatment None

Die attach material

Epoxy 2200D
Wire Au wire
Mold Compound G600
Plating Composition Matte Tin



Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
NSEB164100001.000	TSMC915451595.000	1601H4R
NSEB164100002.000	TSMC915451595.000	1601H4V
NSEB164100003.000	TSMC915451595.000	1601H55

Result	X Pass	Fail	

10L MSOP (3x3mm) assembled by UTL (NSEB) pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020D standard.

PACKAGE QUALIFICATION REPORT						
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020D)	IPC/JEDE C J-STD- 020D	135	0/135	Pass	

<u>Precondition</u>	Electrical Test :+25°C	JESD22-	693(0)	693		Good
Prior Perform	System: TMT_HV_NT	A113				Devices
(At MSL Level 1)	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max			693		
	System: Vitronics Soltec MR1243					
	Electrical Test :+25°C System: TMT_HV_NT			0/693	Pass	

PACKAGE QUALIFICATION REPORT							
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C	
Temp Cycle	Electrical Test: + 25°C System: TMT HV NT		231(0)	0/231	Pass	77 units / lot	
	Bond Strength: Wire Pull (> 4.0 grams) Bond Shear (>20.00 grams)		15 (0) 15 (0)	0/15 0/15	Pass Pass		
	Stress Condition: +130°C/85%RH, 96 hrs.	JESD22- A118		231		Parts had been pre-conditioned at 260°C	
UNBIASED-HAST	System: HAST 6000X Electrical Test: +25°C System: TMT_HV_NT		231(0)	0/231	Pass	77 units / lot	
HAST	Stress Condition: +130°C/85%RH, 96 hrs. Bias Volt: 5.0 Volts System: HAST 6000X	JESD22- A110		231		Parts had been pre-conditioned at 260°C	
	Electrical Test: +25°C System: TMT_HV_NT		231(0)	0/231	Pass	77 units / lot	
High	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		45		45 units	
Temperature Storage Life	Electrical Test :+25°C System: TMT_HV_NT		45(0)	0/45	Pass		

PACKAGE QUALIFICATION REPORT							
Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks		
Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	JESD22B- 102E	22 (0)	22 22 0/22	Pass			
Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	JESD22B- 102E	22 (0)	22 22 0/22	Pass			
Physical Dimension, 30 units from 1 lot	JESD22- B100/B108	30(0) Units	0/30	Pass			
Wire Pull (> 4.0 grams) Bond Shear (>20.00 grams)	M2011 JESD22- B116	30 (0) Wires 30 (0) bonds	0/30	Pass Pass			
	Test Condition Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Physical Dimension, 30 units from 1 lot Wire Pull (> 4.0 grams)	Test Condition Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Physical Dimension, 30 units from 1 lot M2011 Wire Pull (> 4.0 grams) JESD22- B116	Test Condition Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Physical Dimension, 30 units from 1 lot Mire Pull (> 4.0 grams) Standard/ Method JESD22B- 102E 22 (0) JESD22B- 102E 30(0) Wires M2011 M2011 30 (0) Wires	Test Condition	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.245°C Solder material: Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection JESD22B- 22 O/22 Pass O/22 O/22 Pass O/22 O/22 Pass O/22 O/22 Pass O/22 O/22 Pass O/22 O/22		

CCB 4903 Pre and Post Change Summary PCN #: ASER-15HQCX332



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Qualification of a new lead frame design for selected MCP342xxx device family available in 10L MSOP (3x3mm) package.

Lead Frame Comparison



